

INFORMATION  
DISCLOSURE  
CITATION

Applicant: Atsushi FUJII et al.

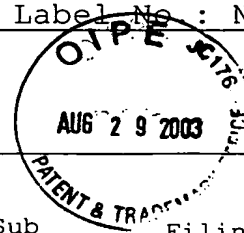
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Filed : June 28, 2001

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Atty.Ref.: Kinoshita 222

Group : 1732



## U.S. PATENT DOCUMENTS

Examiner Initial*	Document Number	Date	Name	Class	Sub Class	Filing Date
57X	AA 3 335 207	08/08/1967	RICHIE			
	AB					
	AC					

## FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Sub Class	Translation Yes No
57X	AD 1 016 518	07/05/2000	EUROPE			(English Language)
57X	AE 2-122919	05/10/1990	JAPAN			
57X	AF 3-169534	07/23/1991	JAPAN			
57X	AG 8-11147	01/16/1996	JAPAN			
57X	AH 56-137937	10/28/1981	JAPAN			
57X	AI 9-57782	03/04/1997	JAPAN			
57X	AJ 9-19968	01/21/1997	JAPAN			

## OTHER DOCUMENTS (Including Author, Title, Date, Pages, Etc.)

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	AA					
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	AE					
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	AG					
	AH					
	AI					
	AJ					
	AK					

## FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Sub Class	Translation Yes No
79L	AL 09-290430	11/1997	Japan	(including English language abstract)		
	AM					
	AN					
	AO					
	AP					

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